

Search Notes

Application/Control No.

10/634,229

Examiner

Sun J. Lin

Applicant(s)/Patent under
Reexamination

BANSAL, JAI P.

Art Unit

2825

SEARCHED

Class	Subclass	Date	Examiner
716	1	2/11/2005	JSL
716	7	2/11/2005	JSL
716	8	2/11/2005	JSL
716	9	2/11/2005	JSL

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
--	------	------

EAST
[USPAT;US-
PGPUB;UPO;JPO;DERWENT;IBM_T
DB]

2/11/2005

JSL